Search Notes



App	lica	tion	/Contr	ol No
-----	------	------	--------	-------

10562458

Applicant(s)/Patent Under Reexamination

BREDERLOW ET AL.

Examiner

JOHN F MORTELL

4154

Art Unit

SEARCHED

Class	Subclass	Date	Examiner
340	572.100	3/10/2008	/JM/

SEARCH NOTES

Search Notes	Date	Examiner
PALM Inventor Name Search	3/10/2008	/JM/
EAST Search Notes Included	3/5-3/13/2008	/JM/
NPL: ACM Digital Library: AC RFID tag	3/19/2008	/JM/
Confer with Benjamin Lee, Supervisory Patent Examiner	5/4/2009	/JM/
EAST: update search; search notes included.	5/11/2009	/JM/
Confer with Daniel Wu, Supervisory Patent Examiner	11/19/2009	/JM/
EAST: update search; search notes included.	11/19,	/JM/
	12/2/2009	

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

U.S. Patent and Trademark Office Part of Paper No.: 20091118